FARO Technologies, Inc. Logo

FARO to present at 2012 Stephens Fall Investment Conference

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LAKE MARY, Fla., Nov. 7, 2012 /PRNewswire/ -- FARO Technologies, Inc., (Nasdaq: FARO) the most trusted source in 3D measurement and imaging solutions, announced that President and CEO Jay Freeland and Senior Vice President and CFO Keith Bair will present at the 2012 Stephens Fall Investment Conference on Tuesday, November 13, 2012 at 4:00pm EST at the New York Palace Hotel in New York City.

(Logo: http://photos.prnewswire.com/prnh/20110415/MM84316LOGO)

The audio will be simultaneously web cast at www.faro.com/stephens-conference

FARO recommends registering at least 15 minutes prior to the start of the presentation to ensure timely access.

For more information on the FARO's global industries, applications and products, visit www.faro.com.

About FARO

FARO is the world's most trusted source for 3D measurement technology. The Company develops and markets computer-aided measurement and imaging devices and software. Technology from FARO permits high-precision 3D measurement, imaging and comparison of parts and compound structures within production and quality assurance processes. The devices are used for inspecting components and assemblies, production planning, documenting large volume spaces or structures in 3D, surveying and construction, as well as for investigation and reconstruction of accident sites or crime scenes.

Worldwide, approximately 15,000 customers are operating more than 30,000 installations of FARO's systems. The Company's global headquarters is located in Lake Mary, Fla., its European head office in Stuttgart, Germany and its Asia/Pacific head office in Singapore. FARO has branches in Brazil, Mexico, Germany, United Kingdom, France, Spain, Italy, Poland, Netherlands, India, China, Singapore, Malaysia, Vietnam, Thailand and Japan.

Further information: http://www.faro.com.

SOURCE FARO Technologies, Inc.

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